

Search Notes

Application/Control No.

10/601,253

Examiner

Hong C. Kim

Applicant(s)/Patent under
Reexamination

JEDDELOH ET AL.

Art Unit

2185

SEARCHED

Class	Subclass	Date	Examiner
See attach		1/4/08	ick

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
See attach	1/4/08	ick